SCAS131 – APRIL 1990 – REVISED APRIL 1993

•	Inputs Are TTL-Voltage Compatible Specifically Designed for Data		T PACKAGE VIEW)
	Synchronization Applications		
•	Improved Metastable Characteristics Provide Greater System Reliability	1Q 1 2Q 2 3Q 3	24 1 OE 23 1 1D 22 20
•	3-State Outputs Drive Bus Lines Directly	4Q 4	21 3D
•	Flow-Through Architecture to Optimize	GND 🛛 5	20 🛛 4D
	PCB Layout	GND 🛛 6	19 V _{CC}
•	Center-Pin V _{CC} and GND Configurations to	GND 🛛 7	18 🛛 V _{CC}
	Minimize High-Speed Switching Noise	GND 🛛 8	17 🛛 5D
•	EPIC [™] (Enhanced-Performance Implanted	5Q 🛛 9	16 6D
	CMOS) 1-µm Process	6Q 🛛 10	15 7D
		7Q 🛿 11	14 🛛 8D
•	500-mA Typical Latch-Up Immunity at 125°C	8Q 🛛 12	13] CLK
•	Package Options Include Plastic Small		

 Package Options Include Plastic Small Outline Packages and Standard Plastic 300-mil DIPs

description

The 74ACT11478 is an 8-bit dual-rank synchronizer circuit designed specifically for data synchronization applications where the normal setup and hold time specifications are frequently violated.

Synchronization of two digital signals operating at different frequencies is a common system problem. This problem is typically solved by synchronizing one of the signals to the local clock through a flip-flop. This solution, however, causes the setup and hold time specifications associated with the flip-flop to be violated. When the setup or hold time specification is violated, the output response is uncertain.

A flip-flop is metastable if its output hangs up in the region between V_{IL} and V_{IH} . The metastable condition lasts until the flip-flop recovers into one of its two stable states. With conventional flip-flops, this recovery time can be longer than the specified maximum propagation delay.

The problem of metastability is typically solved by adding an additional layer of synchronization. This type of dual ranking is employed in the 74ACT11478. The probability of the second stage entering the metastable state is exponentially reduced by this dual-rank architecture. The 74ACT11478 provides a one-chip solution for system designers in asynchronous applications.

The 74ACT11478 is characterized for operation from – 40°C to 85°C.

(each flip-flop)						
	INPUTS	OUTPUT				
OE	CLOCK [†]	D	Q			
Н	Х	Х	Z			
L	\uparrow	L	L			
L	\uparrow	Н	н			
L	Н	Х	QO			

FUNCTION TABLE

[†] Data presented at the D input requires two clock cycles to appear at the Q output.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

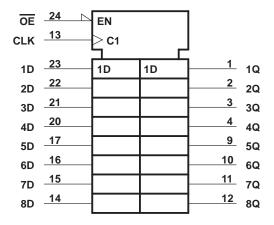


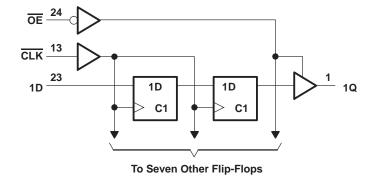
Copyright © 1993, Texas Instruments Incorporated

SCAS131 - APRIL 1990 - REVISED APRIL 1993

logic symbol[†]

logic diagram (positive logic)





[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC}	– 0.5 V to 7 V
Input voltage range, VI (see Note 1)	-0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	-0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{CC})	
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	$\dots \dots \pm 50 \text{ mA}$
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	$\dots \dots \pm 50 \text{ mA}$
Continuous current through V _{CC} or GND	$\dots \dots \pm 200 \text{ mA}$
Storage temperature range	– 65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

		MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	V
VIH	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
VO	Output voltage	0	VCC	V
ЮН	High-level output current		- 24	mA
IOL	Low-level output current		24	mA
$\Delta_{t/\Delta V}$	Input transition rise or fall rate	0	10	ns /V
TA	Operating free-air temperature	- 40	85	°C



SCAS131 - APRIL 1990 - REVISED APRIL 1993

electrical characteristics	over	recommended	operating	free-air	temperature	range	(unless
otherwise noted)					-	•	

DADAMETED			T,	₄ = 25° α	;				
PARAMETER	TEST CONDITIONS V _{CC}		MIN	TYP	MAX	MIN	MAX	UNIT	
	1	4.5 V	4.4			4.4			
	I _{OH} = – 50 μA	5.5 V	5.4			5.4			
VOH		4.5 V	3.94			3.8		V	
	I _{OH} = - 24 mA		4.94			4.8			
	I _{OH} = – 75 mA [†]	5.5 V				3.85			
	I _{OL} = 50 μA	4.5 V			0.1		0.1		
		5.5 V			0.1		0.1	V	
VOL	I _{OL} = 24 mA	4.5 V			0.36		0.44		
		5.5 V			0.36		0.44		
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65		
I _{OZ}	$V_{O} = V_{CC}$ or GND	5.5 V			± 0.5		± 5	μA	
lj	$V_I = V_{CC}$ or GND	5.5 V			± 0.1		± 1	μΑ	
ICC	$V_{I} = V_{CC} \text{ or GND}, \qquad I_{O} = 0$	5.5 V			8		80	μA	
ΔI_{CC}^{\ddagger}	One input at 3.4 V, Other inputs at GND or V_{CC}	5.5 V			0.9		1	mA	
Ci	V _I = V _{CC} or GND	5 V		4.5				pF	
Co	$V_{O} = V_{CC}$ or GND	5 V		12				pF	

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

[‡]This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

				T _A = 25°C MIN MAX				
						MIN	MAX	UNIT
f _{clock}	Clock frequency			0	75	0	75	MHz
	Dula duration	CLK high		4		4		
tw	Pulse duration CLK low	5		5		ns		
t _{su}	Setup time, data before CLK↑			2.7		2.7		ns
t _h	Hold time, data after $CLK\uparrow$			1.5		1.5		ns

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

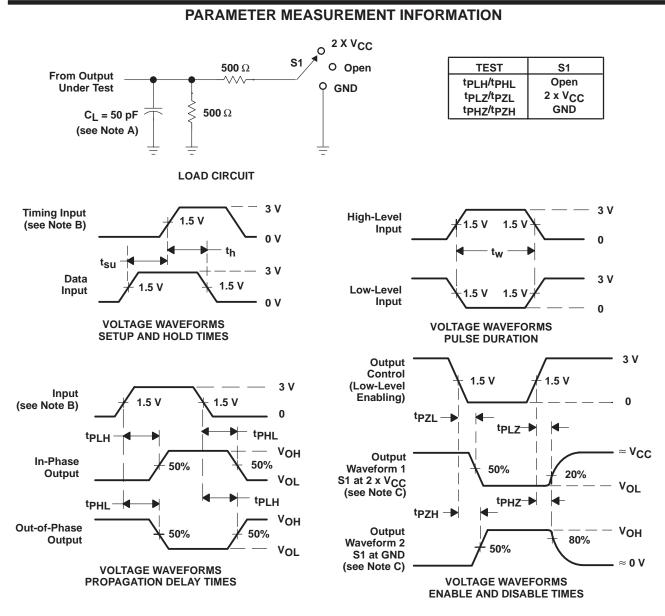
DADAMETED	FROM	TO $T_A = 25^{\circ}C$		T _A = 25°C				
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	UNIT
fmax			7.5			75		MHz
^t PLH		0	4.3	7.4	10.1	4.3	11.6	
^t PHL	CLK	Q	5.6	9.4	12.6	5.6	14.2	ns
^t PZH		0	3.7	7.5	11.1	3.7	12.6	
^t PZL	OE	Q	4.7	9.2	13.7	4.7	15.8	ns
^t PHZ			4.4	7.2	9.2	4.4	9.8	
^t PLZ	OE	Q	4.7	6.6	8.7	4.7	9.3	ns



SCAS131 - APRIL 1990 - REVISED APRIL 1993

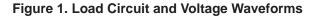
operating characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$

PARAMETER		TEST CONDITIONS	TYP	UNIT	
		Outputs enabled		76	
Cpd	Power dissipation capacitance per flip-flop	Outputs disabled	$C_L = 50 \text{ pF}, \qquad f = 1 \text{ MHz}$	64	pF



NOTES: A. CL includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f = 3 ns, t_f = 3 ns.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
- Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.





IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DLP® Products	www.dlp.com	Broadband	www.ti.com/broadband
DSP	dsp.ti.com	Digital Control	www.ti.com/digitalcontrol
Clocks and Timers	www.ti.com/clocks	Medical	www.ti.com/medical
Interface	interface.ti.com	Military	www.ti.com/military
Logic	logic.ti.com	Optical Networking	www.ti.com/opticalnetwork
Power Mgmt	power.ti.com	Security	www.ti.com/security
Microcontrollers	microcontroller.ti.com	Telephony	www.ti.com/telephony
RFID	www.ti-rfid.com	Video & Imaging	www.ti.com/video
RF/IF and ZigBee® Solutions	www.ti.com/lprf	Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2009, Texas Instruments Incorporated